

#### **Features**

- Wide bandgap SiC MOSFET technology
- Low On-Resistance with High Blocking Voltage
- Low Capacitances with High-Speed switching
- Low reverse recovery(Qrr)
- Halogen free, RoHs compliant

#### **Benefits**

- Reduce switching losses
- Increased system Switching Frequency
- Increased power density
- · Reduction of heat sink reguirements

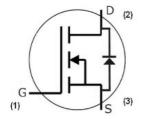
## **Applications**

- Switch mode power supplies
- Renewable energy
- On Board Charger
- High Voltage DC/DC Converters









**Maximum Ratings** (T<sub>c</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Value	Unit	Note
V <sub>DSmax</sub>	Drain-Source Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = 100μA	650	V	
$V_{G m Smax}$	Gate-Source voltage	AC (f > 1 Hz)	-10/+25	V	
$V_{GSop}$	Recommend Gate-Source Voltage	Static	-4/+18	V	
,	Continuous Drain current	V <sub>GS</sub> = 18V, T <sub>C</sub> = 25°C	18	А	Fig. 14
I <sub>D</sub>		$V_{\rm GS}$ = 18V, $T_{\rm C}$ = 100°C	13		
$I_{D,pulse}$	Pulsed Drain Current	Pulse with $t_p$ limited by $T_{jmax}$	28	А	
$P_D$	Power Dissipation	T <sub>C</sub> = 25°C, Tj = 175°C	43	W	Fig. 16
$T_{\rm j}$	Operating junction temperature		-55~175	°C	
$\mathcal{T}_{stg}$	Storage temperature		-55~175	°C	



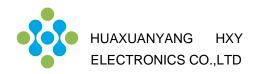
## **Thermal Characteristics**

Symbol	Parameter		Value	Unit	Note	
Symbol	i didilictei	Min.	Тур.	Max.	O I III	Note
$R_{th(jc)}$	Thermal resistance from Junction to Case		3.46		K/W	Fia. 45
$R_{th(ja)}$	Thermal resistance from Junction to Ambient		40		K/W	Fig. 15

## **Electrical Characteristics** (T<sub>C</sub> = 25°C unless other wise specified)

## **Static Characteristics**

Cumbal	Parameter	Toot conditions	Value			Unit	Note
Symbol		Test conditions	Min.	Тур.	Max.	Unit	Note
V <sub>(BR)DSS</sub>	Drain-Source Breakdown voltage	$V_{GS} = 0V, I_D = 100 \mu A$	650			V	
Vasuu	Gate Threshold voltage	$V_{GS} = V_{DS}$ , $I_D = 5$ mA		2.7		V	Fig. 9
V <sub>GS(th)</sub>		$V_{GS} = V_{DS}, I_D = 5\text{mA}, T_j = 175^{\circ}\text{C}$		1.8			1 ig. 9
I <sub>GSS</sub>	Gate-Source Leakage current	$V_{GS} = 20$ V, $V_{DS} = 0$ V			250	nA	
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 650 \text{V}, \ V_{GS} = 0 \text{V}, \ T_j = 25^{\circ}\text{C}$		1	50	μА	
	Drain-Source On-state Resistance	$V_{GS} = 18V, I_D = 10A$ $V_{GS} = 20V, I_D = 10A$		105 94	150		Fig. 3, 4,
R <sub>DS(on)</sub>		$V_{GS}$ = 18V, $I_D$ =10A, $T_j$ = 175°C $V_{GS}$ = 20V, $I_D$ =10A, $T_j$ = 175°C		140 130		mΩ	5
<b>G</b> fs	Transconductance	$V_{DS} = 20 \text{V}, I_D = 10 \text{A}$		13			
		$V_{DS} = 20V, I_D = 10A, T_j = 175^{\circ}C$		9		S	Fig. 6



# **Gate Charge Characteristics**

Symbol	Parameter	Test conditions -	Value			Unit	Note
Symbol			Min.	Тур.	Max.	Oilit	Note
Qes	Gate to Source Charge	V <sub>DS</sub> = 400V		8.3			
$Q_{GD}$	Gate to Drain Charge	$I_D = 10A$ $V_{GS} = -4V/18V$		12.1		nC	Fig. 10
Q <sub>G</sub>	Total Gate Charge			35.8			

### **AC Characteristics**

Symbol	Parameter	Test conditions	Value			Unit	Note
Syllibol			Min.	Тур.	Max.	Oilit	Note
Ciss	Input Capacitance	$V_{GS} = 0V$ , $V_{DS} = 600V$		767		pF	
Coss	Output Capacitance	f =1 MHz V <sub>AC</sub> = 25mV		55		pF	Fig. 13
C <sub>rss</sub>	Reverse Transfer Capacitance			7		pF	
R <sub>G(int)</sub>	Internal Gate Resistance	f=1 MHz, V <sub>AC</sub> = 25mV		2.8		Ω	

## **Reverse Diode Characteristics**

Symbol	Parameter	Test conditions	Value			Unit	Note
			Min.	Тур.	Max.	Offic	Note
V	Diode Forward Voltage	V <sub>GS</sub> =-5V, I <sub>SD</sub> =7.5A		4.0		- v	Fig. 7,8
V <sub>SD</sub>		$V_{GS}$ =-5V, $I_{SD}$ =7.5A, $T_{j}$ = 175°C		3.5			
Is	Continuous Diode Forward Current	$V_{\rm GS}$ =-5V , $T_{\rm C}$ = 25°C		10		Α	
I <sub>S, pulse</sub>	Diode pulse Current	$V_{GS}$ =-5V,pulse width $t_p$ limited by $T_{jmax}$		28		A	



## **Typical Performance**

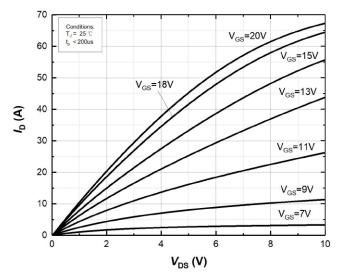


Figure 1. Output characteristics at Tj=25°C

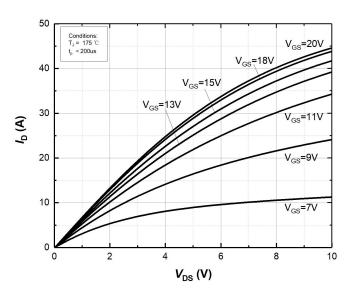


Figure 2. Output characteristics at Tj=175°C

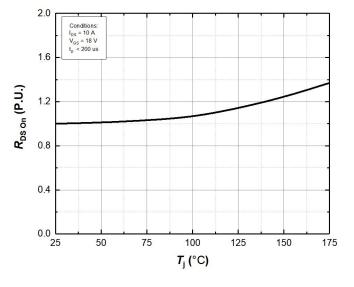


Figure 3. Normalized On-Resistance vs. Temperature

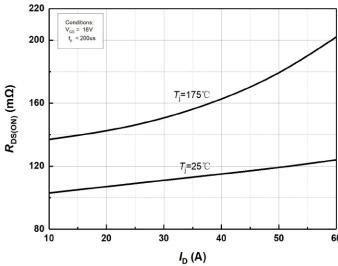
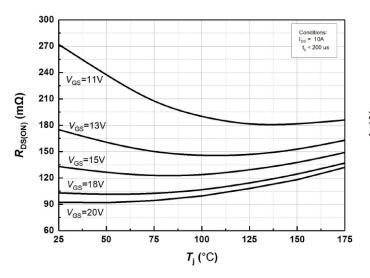


Figure 4. On-Resistance vs. Drain current for Various Temperature



100
Conditions:
V<sub>0.5</sub> = 18V
t<sub>s</sub> < 200 us

40

7<sub>j</sub>=175°C

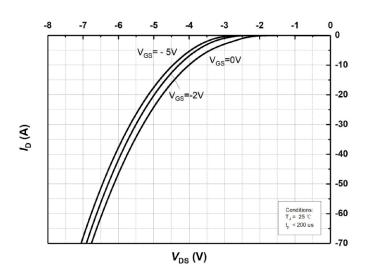
7<sub>j</sub>=25°C

20

V<sub>GS</sub>(V)

Figure 5. On-Resistance vs. Temperature for Various Gate Voltage

Figure 6. Transfer Characteristics for Various Junction Temperatures



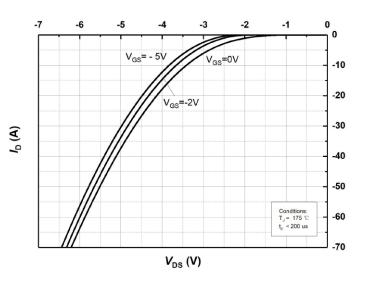


Figure 7. Body Diode Characteristics at Tj=25°C

Figure 8. Body Diode Characteristics at Tj=175°C

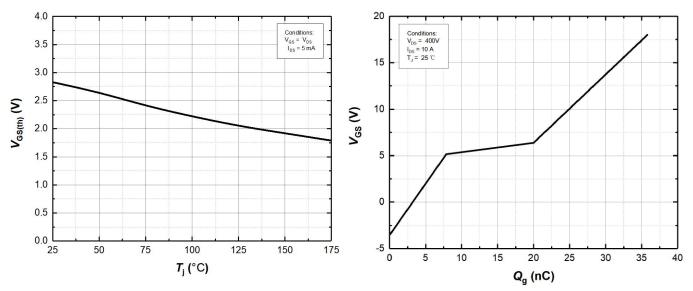


Figure 9. Threshold Voltage vs. Temperature

**Figure 10 Gate Charge Characteristics** 

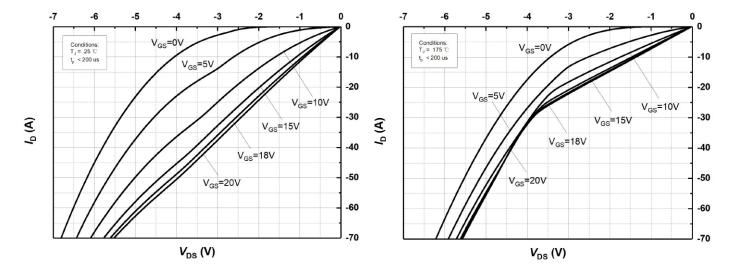


Figure 11. 3rd Quadrant Characteristic at Tj=25°C

Figure 12. 3rd Quadrant Characteristic at Tj=175°C

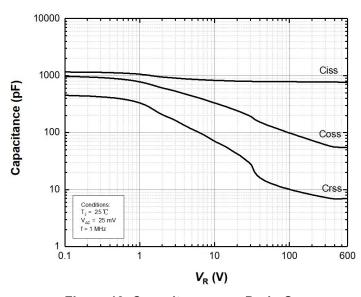


Figure 13. Capacitances vs. Drain-Source Voltage (0 – 600V)

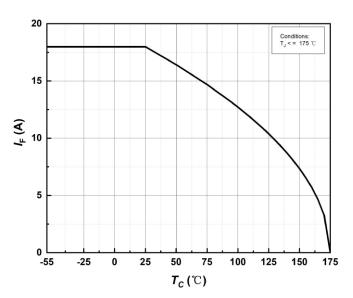


Figure 14. Continuous Drain Current
Derating vs Case Temperature

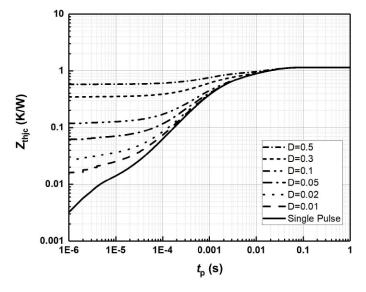


Figure 15.Transient Thermal Impedance (Junction – Case)

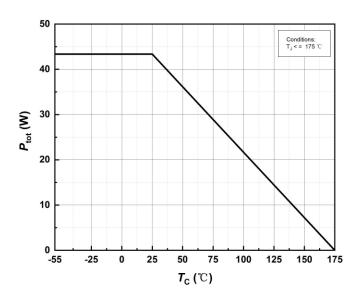


Figure 16. Maximum Power Dissipation Derating vs.

Case Temperature

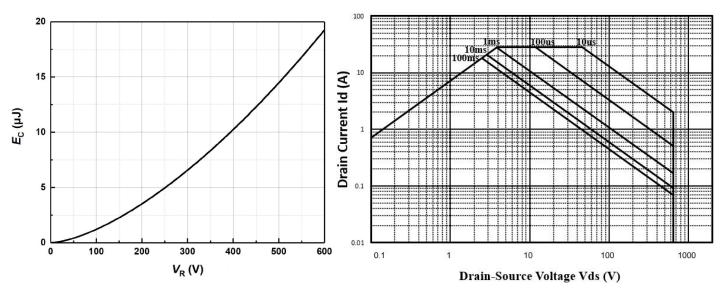
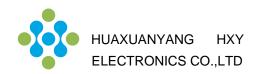


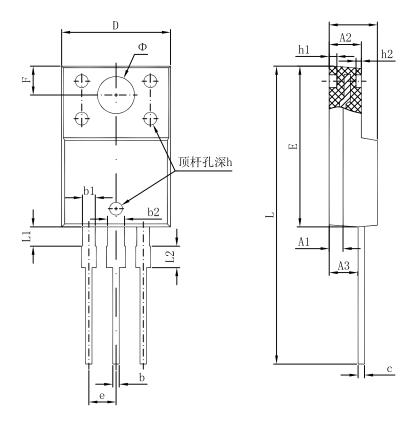
Figure 17. Output Capacitor Stored Energy

Figure 18. Safe Operating Area

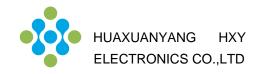


# **Package Dimensions**

Package TO-220F



Cymphol	Dimensions	In Millimeters	Dimensions In Inches			
Symbol	Min.	Max.	Min.	Max.		
Α	4.300	4.700	0.169	0.185		
A1	1.300	REF.	0.051	REF.		
A2	2.800	3.200	0.110	0.126		
A3	2.500	2.900	0.098	0.114		
b	0.500	0.750	0.020	0.030		
b1	1.100	1.350	0.043	0.053		
b2	1.500	1.750	0.059	0.069		
С	0.500	0.750	0.020	0.030		
D	9.960	10.360	0.392	0.408		
E	14.800	15.200	0.583	0.598		
е	2.540	TYP.	0.100	TYP.		
F	2.700	REF.	0.106	REF.		
Φ	3.500	REF.	0.138	REF.		
h	0.000	0.300	0.000	0.012		
h1	0.800 REF.		0.031 REF.			
h2	0.500	REF.	0.020	REF.		
L	28.000	28.400	1.102	1.118		
L1	1.700	1.900	0.067	0.075		
L2	1.900	2.100	0.075	0.083		



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